Notice of	of Refer	ences	Cited
-----------	----------	-------	-------

79		
Application/Control No.	Applicant(s)/Pater	nt Under
09/829,797	Reexamination LIANG ET AL.	
Examiner	Art Unit	
Monica Lewis	2822	Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number	Date	Name	Classification
L		Country Code-Number-Kind Code	MM-YYYY	Ivame	Classification
	Α	US-6,313,540	11-2001	Kida et al.	257/784
	В	US-2002/0187634	12-2002	Saran et al.	438/669
-	С	US-5,736,791	04-1998	Fujiki et al.	257/781
,	D	US-5,923,088	07-1999	Shiue et al.	257/758
	E	US-6,100,589	08-2000	Tanaka	257/758
	F	US-6,297,563	10-2001	Yamaha	257/781
	G	US-6,465,337 /	10-2002	Lee et al.	438/612
	Н	US-6,524,942	02-2003	Tsai et al.	438/612
	١	US-6,552,438 /	04-2003	Lee et al.	257/784
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Τ					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.